

P-Channel 30-V (D-S) MOSFET

Description

The device is the highest performance trench P-ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The device meets the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- $R_{DS(ON)} = 12m\Omega@V_{GS} = -10V$
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Typical Applications

- MB / VGA / Vcore
- POL Applications
- Load Switch
- LED Applications

Package type: SOP-8

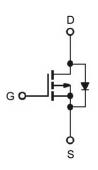
Packing & Order Information

3,000/Reel

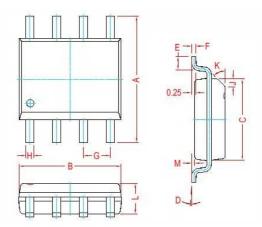


RoHS Compliant

Graphic Symbol

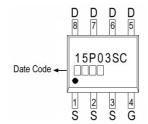


Package Dimension



REF.	Millimeter		REF.	Millimeter		
	Min.	Max.	IXLI.	Min.	Max.	
Α	5.80	6.20	М	0.10	0.25	
В	4.80	5.00	Н	0.35	0.51	
С	3.80	4.00	L	1.35	1.75	
D	0°	8°	J	0.40 Ref.		
Е	0.40	0.90	K	45° Ref.		
F	0.19	0.26	G	1.27 Typ.		

Marking





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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Units		
V_{DS}	Drain-Source Voltage	-30	V		
V _{GS}	Gate-Source Voltage	±20	V		
I _D	Continuous Drain Current ¹ (T _C =25°C)	-15	Α		
	Continuous Drain Current ¹ (T _C =70°C)	-12	A		
I _{DM}	Pulsed Drain Current ^{1,2}	-45	A		
1_	Continuous Drain Current ¹ (T _A =25°C)	-9.0	А		
I _D	Continuous Drain Current ¹ (T _A =70°C)	-7.2	A		
I _{AS}	Single Pulse Avalanche Current, L =0.1mH ³	-46	A		
E _{AS}	Single Pulse Avalanche Energy, L =0.1mH ³	105	mJ		
P _D	Power Dissipation ⁴ (T _A =25°C)	1.5	W		
T _J /T _{STG}	Operating Junction and Storage Temperature	-55 to +150	°C		

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
$R_{ heta JA}$	Maximum Junction-to-Ambient ¹	85	°C/W		
$R_{\theta JC}$	Maximum Junction-to-Case ¹	30	°C/W		

Electrical Characteristics (T _J =25°C unless otherwise specified)							
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units	
V _{GS (th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1.0	-	-2.5	V	
BV_{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-30	-	-	V	
g _{fs}	Forward Transconductance	V _{DS} =-5V, I _D =-10A	-	24	-	S	
I_{GSS}	Gate-Source Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-24V, V _{GS} =0V, T _J =25°C	-	-	-1	μΑ	
		V _{DS} =-24V, V _{GS} =0V, T _J =55°C			-5		
R _{DS (on)}	Static Drain-Source On-Resistance ²	V _{GS} =-10V, I _D =-12A	-	-	12	mΩ	
		$V_{GS} = -4.5V, I_{D} = -8A$	-	-	20		
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =-25V, L =0.1mH, I _{AS} =-33A	54		-	mJ	
V_{SD}	Diode Forward Voltage ²	I _S =-12A, V _{GS} =0V, T _J =25°C	-	-	-1.2	V	
Is	Continuous Source Current ^{1,6}	V V OV Force Current	-	-	-15		
I _{SM}	Pulsed Source Current ^{2,6}	V _G =V _D =0V, Force Current	-	-	-45	Α	

Notes

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.
- 3. The EAS data shows maximum rating. The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.1mH, I_{AS} =-46A.
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



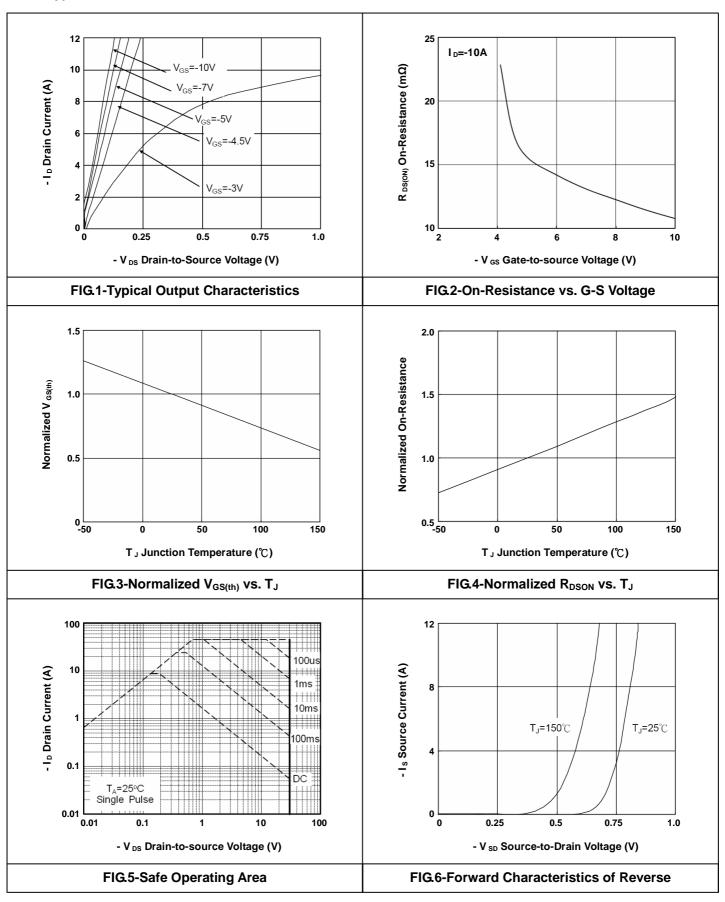
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Dynamic							
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units	
Qg	Total Gate Charge ²	V _{DS} =-15V		20			
Q_{gs}	Gate-Source Charge	I _D =-10A		5.1		nC	
Q _{gd}	Gate-Drain Charge	V _{GS} =-4.5V		7.3			
t _{d(on)}	Turn-On Delay Time ²	V _{DS} =-15V		33.8			
t _r	Rise Time	I _D =-1A		35.8			
t _{d(off)}	Turn-Off Delay Time	V _{GS} =-10V		72.8		ns	
t _f	Fall Time	$R_G = 3.3\Omega$		10.5			
C _{ISS}	Input Capacitance	V _{DS} =-15V		2215			
Coss	Output Capacitance	V _{GS} =0V		310		pF	
C _{RSS}	Reverse Transfer Capacitance	f =1.0MHz		237			
Rg	Gate Resistance	V _{GS} =V _{DS} =0V, f =1.0MHz		9		Ω	



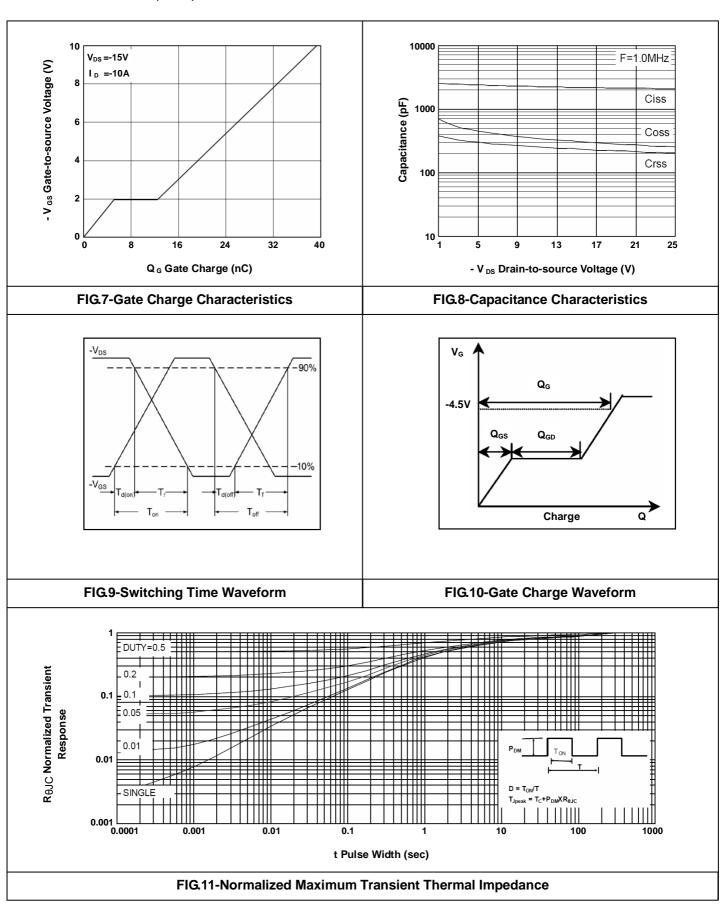
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• Typical Electrical Characteristics





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